

EXPRESS MAIL LABEL NO.: EV343426598US

PATENT  
627-P0001

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of : Applications Branch  
Michael SCHEIDELL  
Serial No.: Not Yet Assigned  
Filed: HEREWITH  
For: INTRUSION DETECTION SYSTEM

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

The attached Form PTO-1449 provides a listing of information which may be relevant to the subject application. This IDS is not intended as a representation that better art is not available, nor that other art than that identified exists; nor that the information provided is prior art; nor that a search has been made.

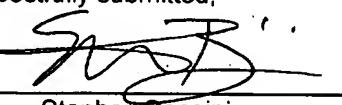
This IDS is submitted under:

- XX 37 CFR 1.97(b) - No Fee.  
       37 CFR 1.97(c) - No Fee, with Certification.  
       37 CFR 1.97(c) - Fee.  
       37 CFR 1.97(d) - Fee and Certification.

The Commissioner is authorized to charge any required fees under 37 CFR 1.17(p) and (i)(1) to Deposit Account No. 50-1556.

Date: 10/30/03

Respectfully submitted,

By: 

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Form PTO-1449	U.S. Dept. of Commerce Patent & Trademark Office	Atty. Docket: 627-P0001	Serial No. Not Yet Assigned
List of Documents Cited by Applicant (Use several sheets if necessary)		Applicant: Michael SCHEIDELL	
		Filing Date: HEREWITH	

## **U.S. PATENT DOCUMENTS**

## **FOREIGN PATENT DOCUMENTS**

**OTHER DOCUMENTS** (Including Author, Title, Date, Pertinent Pages, Etc.)

	AA5	Watson, Peter, "An Approach to IDS," SANS Institute Resources (2002), <a href="http://www.sans.org.newlook/resources/IDFAQ/layered_defense.htm">http://www.sans.org.newlook/resources/IDFAQ/layered_defense.htm</a>
	AA6	Reeder, Paul, "Intrusion Detection: Adding Depth to Network Defense," Networking News & Analysis (April 25, 2001)
	AA7	Phung, Manh, "Data Mining in Intrusion Detection," SANS Institute (October 24, 2000)

Examiner:	Date Considered:
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**EXAMINER:** Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.